

DESCRIPTION:

Hall Probe H for F3A Magnetic Transducers is a very thin (1.1mm) and long (42mm) single-chip fully integrated 3-axis Hall-Probe.

The Hall Probe H for F3A Magnetic Transducers contains a CMOS integrated circuit, which incorporates three groups of mutually orthogonal Hall elements, biasing circuits, amplifiers, and a temperature sensor. The integrated Hall elements occupy very small area (150µm x 150µm), which provides very high spatial resolution of the probe. The CMOS IC technology enables very high precision in the fabrication of the vertical and horizontal Hall elements, which gives high angular accuracy (orthogonality error < 0.1°) of the three measurement axis of the probe. The on-chip application of the spinning-current technique in the biasing of the Hall elements suppresses the planar Hall effect. The on-chip signal pre-processing enables a very high frequency bandwidth (DC to 25 kHz) of the probe; and on-chip signal amplification provides high output signals of the Hall probe.

The sensor chip is embedded in the probe package and connected to the CaH cable.

The output of the Hall Probe are high-level analog voltages proportional with each of the measured components of a magnetic flux density and a voltage proportional with the probe temperature.

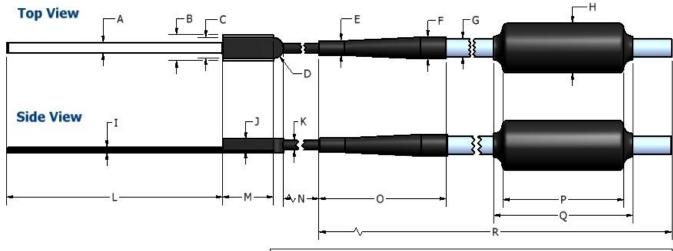
KEY FEATURES:

- The H Hall probe is very thin (1.1mm) and long (42mm) probe with protected Si chip
- Fully integrated CMOS 3-axis (Bx, By, Bz) Hall Probe, of which one, two, or three channels are used
- Very high spatial resolution (By: 0.03 x 0.005 x 0.03mm³; Bx and Bz: 0.15 x 0.01 x 0.15 mm³)
- High angular accuracy (orthogonality error less than 0.1°)
- High frequency bandwidth (from DC up to 25kHz)
- Virtually no planar Hall effect
- Negligible inductive loops on the Probe
- Integrated temperature sensor on the probe for temperature compensation
- The Hall Probe H for F3A Magnetic Transducers is consisting part (Module H) of the F3A Magnetic Field Transducer, Digital Teslameter and Magnetic Field Mapper
- Suitable for as 3-axis (03, XYZ), 2-axis (XY, XZ, YZ) and as 1-axis (0X, 0Y, 0Z) Hall Probe
- Available as a separate unit for OEM customers





PROBE DIMENSIONS AND CHARACTERISTICS:



Probe Dimensions & Tolerances							
Dimension	[mm]	Dimension	[mm]	Dimension	[mm]		
Α	2.0 +/- 0.1	G	4.8 +/- 0.2	М	10.0 +/- 0.1		
В	5.0	Н	16 +/- 1	N	50 +/- 1		
С	4.0 +/- 0.1	I	1.1 +/- 0.1	0	35 +/- 3		
D	R2.0 +/- 0.1	J	2.2 +/- 0.1	Р	30 +/- 1		
E	3.8 +/- 0.2	К	1.5 +/- 0.2	Q	50 +/- 2		
F	6.0 +/- 0.2	L	42.3 +/- 0.2	R	XX +/- 1%		

Figure 1: Dimensions of H Hall probe and Cable (Module H)

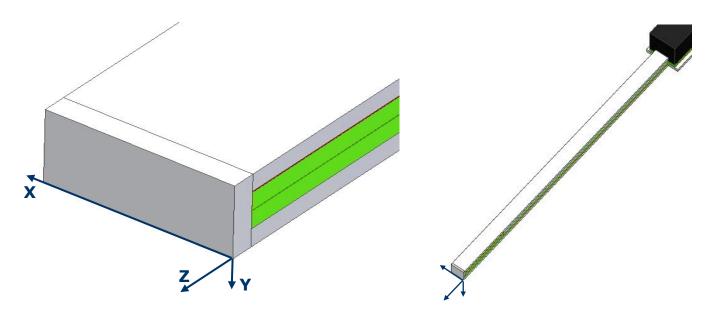


Figure 2: The reference Cartesian coordinate system of H Hall probe



Hall Probe H for F3A Magnetic Field Transducers

Fully Integrated 1-, 2-, 3-axis Hall Probe

Dimension	X [mm]	Y [mm]	Z [mm]		
Magnetic field sensitive volume (MFSV)	0.15	0.01	0.15		
Position of the center of MFSV (corresponding to MFSP, see <i>Fig.1</i>)	1.0 ± 0.1	-0.6 ± 0.05	-0.6 ± 0.1		
	• 2.0 ± 0.1 - Longer, thinner part	1.1 ± 0.1Longer, thinner part	42.3 ± 0.2Longer, thinner part		
Total Probe external dimensions	• 4.0 ± 0.1 / <u>0.5</u> Shorter, thicker part of the probe / <u>ref.</u> <u>ceramics</u>	• 2.0 ± 0.1 - Shorter, thicker part of the probe	• 12.0 ± 0.1 - Shorter, thicker part of the probe		
Angular accuracy of the axes	± 0.5° with respect to the reference surface				
CaH Cable	Shielded, with a flexible thin part near the probe				
 Standard: 2 m (Probe notation: 03H02) Optional: xx m (Probe notation: 03Hxx) Note: Different lengths are available upon request. 					

INSTALLATION MANUAL FOR H HALL PROBE

Warning: the Probe Tip is Fragile!

The probe package is made of ceramics, and can be easily broken. Therefore, avoid any mechanical contact of the probe tip with other objects! Moreover, avoid the immersion of the probe of any liquid, and its exposure to moisture and aggressive gasses.

The following precautions shall help ensure that the transducer accurate calibration remains preserved:

The mounting of the probe should be carried out by application of very low pressure to its back-end and thin wires. If the probe head is clamped, the user should make sure that the substrate surface in contact with the reference plane of the probe is flat and covers as much of the probe reference surface as possible. Do not apply more force than required to hold the probe in its place.

In order to prevent rupture of the thin wires from the probe head, the user should fix and secure the probe cable in the proximity of the probe. The thin wires of the flexible section of the cable may be folded with care; repeated strong bending should be avoided.